

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> ( Not for submission under 37 CFR 1.99)	Application Number		10553818
	Filing Date		2007-02-08
	First Named Inventor	Hytopoulos, Evangelos	
	Art Unit	1614	
	Examiner Name		
	Attorney Docket Number	SEEK-007	

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	3	6455247	B1	2002-09-24	Nolan, Garry P.	
	4	6593511	B1	2003-07-15	Ehrhardt, Rolf	
	5	6656695	B2	2003-12-02	Berg, Ellen L.	
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	1	20030135875	A1	2003-07-17	Ehrhardt, Rolf	
	2	20030138811	A1	2003-07-24	Plavec, Ivan	
	3	20040063088	A1	2004-04-01	Berg, Ellen L.	
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	5	20070072246	A1	2007-03-29	Berg, Ellen L.	
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	1	WO2001067103	WO	A1	2001-09-13	Berg, Ellen L.		<input type="checkbox"/>
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3	WO2003023573	WO	A2	2003-03-20	Berg, Ellen L.		<input type="checkbox"/>
4	WO2004022711	WO	A2	2004-03-18	Plavec, Ivan		<input type="checkbox"/>
5	WO2004087044	WO	A2	2004-10-14	Plavec, Ivan		<input type="checkbox"/>
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7	WO2004094992	WO	A2	2004-11-04	Hytopoulos, Evangelos		<input type="checkbox"/>
8	WO2005023987	WO	A2	2005-03-17	Berg, Ellen L.		<input type="checkbox"/>
9	WO2005093561	WO	A1	2005-10-06	Rosler, Elen		<input type="checkbox"/>
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